

Virtual Reference[™] Analyzer

Characterize your short length optical devices with fast and accurate dispersion measurements

The Virtual Reference™ Analyzer is a fast, accurate and economical system for measuring chromatic dispersion in short length optical components and devices. Based Virtual Reference™ on Interferometer technology, this new system can be used with Agilent/Keysight Technologies 81600 Series tunable lasers to make a fast and accurate dispersion measurement in a single sweep.



Applications:

- Optical component test
- Fiber characterization
- Waveguide measurement
- Nonlinear device test •
- **Quality Assurance**
- **Research & Development**

Features

- Fast single sweep operation
- Highest accuracy measurements
 - Calibration free 0
 - Immune to thermal and vibrational effects
- Simple user interface
- Fast set-up and installation

Measurement Capabilities

- Group Delay
- **Group Velocity Dispersion**
- **Dispersion Parameter**

Interferometry

For characterizing the dispersion properties of short length optical components, interferometers are traditionally used. Interferometers separate light from a source by splitting it into two paths; a well of a physical reference path characterized reference path also makes them prone to and a test path with unknown characteristics. When the light susceptible to thermal beams are brought back together they generate an interference pattern. From this multiple wavelength scans of pattern, information can be obtained about the differences between the two paths and used to determine the dispersion in the test path.

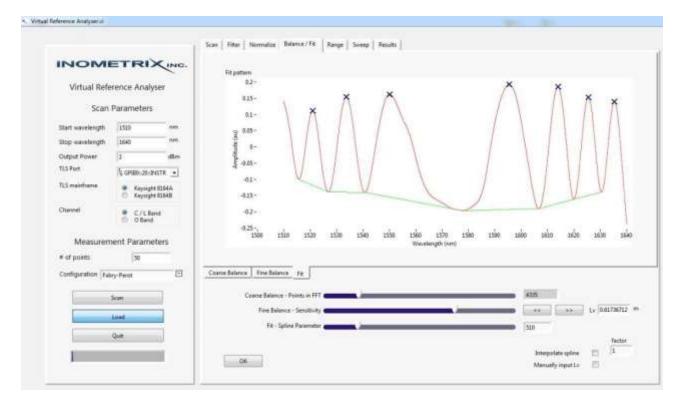
Traditional interferometers are expensive to construct since thev require а physical reference path that must be constructed from hiahlv accurate components. The use calibration errors and and vibrational instabilities. In addition, the approach requires either the source or the receiver in order to fully characterize component а leading to excessive test times.

By replacing the physical reference with a virtual reference these disadvantages can be overcome, a significant advantage for the characterization of short length optical components.

Inometrix Inc. Grimsby, ON Canada



Virtual Reference™ Analyzer



Advantages

Traditional interferometers are often used to characterize short length optical components. Because they use a physical reference path, however, they are expensive, error prone and slow. The Virtual Reference Analyzer from Inometrix Inc. uses Virtual Reference Interferometer technology to replace the physical reference path with a software based 'virtual' path. This improves the accuracy by eliminating calibration error and making it immune to thermal and vibrational noise. It also allows for single sweep characterization, which significantly reduces test time. In addition, the removal of the physical reference path reduces the overall cost of the test equipment required. The Inometrix Virtual Reference Analyzer is used in conjunction with the Agilent/Keysight 816XX A/B series tunable lasers which have operating ranges between 1260nm and 1640nm (Contact us for details). The system measures group delay, group velocity dispersion and the dispersion parameter with an accuracy that meets or exceeds the performance of traditional interferometers.

About Us.

Inometrix Inc. manufactures innovative optical solutions for sensing, testing and imaging applications.

More information including <u>users manuals</u> and <u>demo</u> <u>videos</u> please visit our website at:

www.inometrix.com

Product specifications and descriptions in this document subject to change without notice.

Ordering Information

For more information on Inometrix products, applications or services please contact <u>sales@inometrix.com</u> or your local <u>distributor</u>.



Virtual Reference™ Analyzer

Detailed Specifications		
Operating Range		
Wavelength	1260 — 1640 ⁽¹⁾	nm
Operating Modes	Reflection/Transmission	
Measurement Parameters		
Chromatic Dispersion (CD)	+/- 0.001	ps/nm
Group Delay (GD)	+/- 0.01	ps
Group Delay Range	0.4 - 4	ns
Group Velocity Dispersion (GVD)	+/- 0.001	ps ²
Dispersion Parameter (D)	N/A ⁽²⁾	
Group Velocity (V _G)	N/A ⁽²⁾	
Group Index (N _G)	N/A ⁽²⁾	
Measurement Timing		
Typical Measurement Time	<1	min
Calibration Time	0	min
Measurement Requirements		
Maximum Device Length [typical]	[x + 0.8] ⁽³⁾	m
Minimum Device Length	N/A ⁽⁴⁾	m
Hardware Required: Tunable Laser ⁽⁵⁾		
Tunable Laser Coherence Length	>30	m
Tunable Laser Resolution	< 1	pm
Tunable Laser Data Point Storage	>=100,000	points
Physical Specifications		
Weight	~15	kg
Size (W x D x H)	17 x 16.5 x 6.5	inches
Power and Frequency		
CPU	>2.93	GHz
DAQ	~40	MHz
Power supply (input)	>700, 110-240, 5-11, 50-60	W, V, A, Hz
Financial Information		
Warranty	12	months
Extended Warranty Option	Available	
Financing Option	Available	

(1) Compatible Laser Sources available in this range from Keysight Technologies

(3) Where x is an optional reference path length that can be used to extend the maximum measurable device length

(2) Measurement accuracy is dominated by length measurement accuracy

(4) Depends on laser source bandwidth

(5) Compatible models: Agilent/Keysight 816XX A/B series Tunable lasers